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| 20457 7 | 590 06/28/2005 | | EXAMINER | |
| | I, TERRY, STOUT & KI | JARRETT, | JARRETT, RYAN A | |
| 1300 NORTH SEVENTEENTH STREET SUITE 1800 | | | ART UNIT | PAPER NUMBER |
| ARLINGTON, | ARLINGTON, VA 22209-3873 | | | |

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Please find below and/or attached an Office communication concerning this application or proceeding.

| | | Application No. | Applicant(s) | | | |
|--|--|---|--|--|--|--|
| | | 10/613,148 | NAGATA ET AL. | | | |
| Office Action Summary | | Examiner | Art Unit | | | |
| | • | Ryan A. Jarrett | 2125 | | | |
| Period for | The MAILING DATE of this communicating Reply | ion appears on the cover sheet w | ith the correspondence address | | | |
| THE M - Extens after S - If the p - If NO p - Failure Any re | PRTENED STATUTORY PERIOD FOR IAILING DATE OF THIS COMMUNICATIONS of time may be available under the provisions of 37 KX (6) MONTHS from the mailing date of this communication of the provisions of 37 by the properties of the provisions of 37 kX (6) MONTHS from the mailing date of this communication of the provision of the provis | FION. CFR 1.136(a). In no event, however, may a stion. s, a reply within the statutory minimum of thi y period will apply and will expire SIX (6) MOI by statute, cause the application to become A | reply be timely filed irty (30) days will be considered timely. NTHS from the mailing date of this communication. BANDONED (35 U.S.C. § 133). | | | |
| Status | | | | | | |
| 1)⊠ F |)⊠ Responsive to communication(s) filed on <u>07 July 2003</u> . | | | | | |
| | ☐ This action is FINAL . 2b) ☑ This action is non-final. | | | | | |
| | Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. | | | | | |
| C | nosed in accordance with the practice u | inder <i>Ex par</i> τe Quayie, 1935 C.L | J. 11, 453 O.G. 213. | | | |
| Dispositio | n of Claims | · | | | | |
| 5)□ 0 6)⊠ 0 7)⊠ 0 | Claim(s) <u>1-15</u> is/are pending in the appli a) Of the above claim(s) is/are w Claim(s) is/are allowed. Claim(s) <u>1-5 and 10-15</u> is/are rejected. Claim(s) <u>6-9</u> is/are objected to. Claim(s) are subject to restriction | ithdrawn from consideration. | | | | |
| Applicatio | n Papers | | | | | |
| | he specification is objected to by the Ex | | | | | |
| | he drawing(s) filed on is/are: a)[| | | | | |
| | applicant may not request that any objection Replacement drawing sheet(s) including the | • • • | ` ' | | | |
| | he oath or declaration is objected to by | _ | • | | | |
| | der 35 U.S.C. § 119 | | | | | |
| 12) A A A A A A A A A A A A A A A A A A A | cknowledgment is made of a claim for for All b) Some * c) None of: Certified copies of the priority docu Copies of the certified copies of the application from the International E | uments have been received. uments have been received in A e priority documents have been Bureau (PCT Rule 17.2(a)). | Application No n received in this National Stage | | | |
| Amartin (1 | | , | | | | |
| Attachment(s | i) of References Cited (PTO-892) | 4) Interview S | Summary (PTO-413) | | | |
| 2) D Notice | of Draftsperson's Patent Drawing Review (PTO-9 | 48) Paper No(| s)/Mail Date | | | |
| | tion Disclosure Statement(s) (PTO-1449 or PTO/ lo(s)/Mail Date <u>6/7/05</u> . | (SB/08) 5) Notice of I | nformal Patent Application (PTO-152) | | | |
| S. Patent and Trad PTOL-326 (Rev | | ffice Action Summary | Part of Paper No./Mail Date 06142005 | | | |



DETAILED ACTION

Claim Rejections - 35 USC § 101

1. 35 U.S.C. 101 reads as follows:

Whoever invents or discovers any new and useful process, machine, manufacture, or composition of matter, or any new and useful improvement thereof, may obtain a patent therefor, subject to the conditions and requirements of this title.

2. Claims 11-15 are rejected under 35 U.S.C. 101 because the claimed invention is directed to non-statutory subject matter. The language of the claim raises a question as to whether the claim is directed merely to an abstract idea that is not tied to a technological art, environment, or machine which would result in a practical application producing a concrete, useful, and tangible result to form the basis of statutory subject matter under 35 U.S.C. 101.

The claims are directed to a method that does not require computerimplementation or use of technology to accomplish. The claims allow for the involvement of subjective human decision and therefore do not necessarily produce repeatable, concrete results.

Claim Rejections - 35 USC § 112

3. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

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4. Claims 2 and 5 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Claim 2 recites the limitation "the orthogonal coordinate" in line 5. There is insufficient antecedent basis for this limitation in the claim.

Claim 3 recites the limitation "the data format" in line 14. There is insufficient antecedent basis for this limitation in the claim.

Claim 5 recites the limitation "the bitmap pixel array" in line 4. There is insufficient antecedent basis for this limitation in the claim.

Claim Rejections - 35 USC § 102

5. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 6. Claims 1-5 and 10 are rejected under 35 U.S.C. 102(b) as being anticipated by Cooke US 4.482.810. For example Cooke discloses:
- 1. An exposure apparatus, comprising: a means for applying a charged particle beam or a light onto a sample, and exposing a desired pattern onto the sample; a data processing means for bitmapping the shape of the pattern, and generating the pattern shape data in the bitmap format; and a means for controlling the application of the charged beam or light onto the sample using the pattern shape data in the bitmap format, and the data processing means comprising a function of rejecting an overlap area between patterns from pattern vertex data defining the pattern shape; and a function of

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generating the pattern shape data in the bitmap format based on the result of the overlap rejection function (e.g., col. 3 line 25 – col. 4 line 2, col. 7 line 67 – col. 8 line 12, claims 1-6).

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- 2. The exposure apparatus according to claim 1, wherein the data processing means has a data format for expressing the pattern shape by a pair of opposite corner point coordinates of each line parallel to any one coordinate axis of the orthogonal coordinates (e.g., col. 3 line 25 col. 4 line 2, col. 7 line 67 col. 8 line 12, claims 1-6).
- 3. An exposure apparatus, comprising: a means for applying a charged particle beam or a light onto a sample, and exposing a desired pattern onto the sample; a data processing means for bitmapping the shape of the pattern, and generating the pattern shape data in the bitmap format; and a means for controlling the application of the charged particle beam or light onto the sample using the pattern shape data in the bitmap format, and the data processing means comprising a function of decomposing the pattern shape into plurality of rectangle patterns parallel to any one coordinate axis of the orthogonal coordinates defined on the sample, and converting the pattern shape into a data format for expressing the pattern shape as a pair opposite point coordinates of each line parallel any one coordinate axis of the orthogonal coordinates defined on the sample; a function of grouping corner point data representing the respective rectangle patterns on a per given coordinate area basis, and sorting the respective grouped corner point data by reference to the coordinates of the respective corner point data; and a function of rejecting an overlap area between patterns from the respective sorted corner point data; and a function of generating the pattern shape data in the bitmap format based on the result of the overlap rejection function (e.g., col. 3 line 25 col. 4 line 2, col. 7 line 67 col. 8 line 12, claims 1-6).
- 4. The exposure apparatus according to claim 3, wherein the coordinate area for grouping the respective corner point data is area corresponding to an array of pixels arranged adjacent to each other in a direction parallel to any one coordinate axis of the orthogonal coordinates defined on the sample out of pixel arrays of the bitmap (e.g., Figs. 6-8).
- 5. The exposure apparatus according claim 3, wherein the line formed by the pair of the corner points representing the pattern and the direction of the bitmap pixel array for grouping the corner point

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data are parallel to each other, and the direction of the bitmap pixel array for grouping the corner point data and the direction of scanning of the charged beam or light are parallel to each other (e.g., Figs. 6-8).

- 7. Claims 1-5 and 10 are additionally rejected under 35 U.S.C. 102(b) as being anticipated by Kamiyama et al. US 6,271,852. For example, Kamiyama et al. discloses:
- 1. An exposure apparatus, comprising: a means for applying a charged particle beam or a light onto a sample, and exposing a desired pattern onto the sample; a data processing means for bitmapping the shape of the pattern, and generating the pattern shape data in the bitmap format; and a means for controlling the application of the charged beam or light onto the sample using the pattern shape data in the bitmap format, and the data processing means comprising a function of rejecting an overlap area between patterns from pattern vertex data defining the pattern shape; and a function of generating the pattern shape data in the bitmap format based on the result of the overlap rejection function (e.g., Fig. 30A, Fig. 30B, col. 3 line 35 col. 5 line 17).
- 2. The exposure apparatus according to claim 1, wherein the data processing means has a data format for expressing the pattern shape by a pair of opposite corner point coordinates of each line parallel to any one coordinate axis of the orthogonal coordinates (e.g., Fig. 30A, Fig. 30B, col. 3 line 35 col. 5 line 17).
- 3. An exposure apparatus, comprising: a means for applying a charged particle beam or a light onto a sample, and exposing a desired pattern onto the sample; a data processing means for bitmapping the shape of the pattern, and generating the pattern shape data in the bitmap format; and a means for controlling the application of the charged particle beam or light onto the sample using the pattern shape data in the bitmap format, and the data processing means comprising a function of decomposing the pattern shape into plurality of rectangle patterns parallel to any one coordinate axis of the orthogonal coordinates defined on the sample, and converting the pattern shape into a data format for expressing the pattern shape as a pair opposite point coordinates of each line parallel any one coordinate axis of the orthogonal coordinates defined on the sample; a function of grouping corner point data

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representing the respective rectangle patterns on a per given coordinate area basis, and sorting the respective grouped corner point data by reference to the coordinates of the respective corner point data; a function of rejecting an overlap area between patterns from the respective sorted corner point data; and a function of generating the pattern shape data in the bitmap format based on the result of the overlap rejection function (e.g., Fig. 30A, Fig. 30B, col. 3 line 35 – col. 5 line 17).

- 4. The exposure apparatus according to claim 3, wherein the coordinate area for grouping the respective corner point data is area corresponding to an array of pixels arranged adjacent to each other in a direction parallel to any one coordinate axis of the orthogonal coordinates defined on the sample out of pixel arrays of the bitmap (e.g., Fig. 30A, Fig. 30B, col. 3 line 35 col. 5 line 17).
- 5. The exposure apparatus according claim 3, wherein the line formed by the pair of the corner points representing the pattern and the direction of the bitmap pixel array for grouping the corner point data are parallel to each other, and the direction of the bitmap pixel array for grouping the corner point data and the direction of scanning of the charged beam or light are parallel to each other (e.g., Fig. 30A, Fig. 30B, col. 3 line 35 col. 5 line 17).

Allowable Subject Matter

8. Claims 6-9 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

Conclusion

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ryan A. Jarrett whose telephone number is (571) 272-3742. The examiner can normally be reached on 10:00-6:30 M-F.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Leo Picard can be reached on (571) 272-3749. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

L-P.P

Ryan A. Jarrett Examiner Art Unit 2125

6/14/05

LEO PICARD SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100